

<b>Notice of References Cited</b>	Application/Control No. 10/574,193		Applicant(s)/Patent Under Reexamination AALTONEN ET AL.	
	Examiner OLUMIDE T. AJIBADE AKONAI		Art Unit 2617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0203630	10-2004	Wang, Charles Chuanming	455/414.1
*	C	US-2002/0183059	12-2002	Noreen et al.	455/427
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#### NON-PATENT DOCUMENTS

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